

## **MOSFET**

## OptiMOS<sup>™</sup> 5 Power-Transistor, 60 V

#### **Features**

- Optimized for synchronous rectification
  N-channel, normal level
  Superior thermal resistance

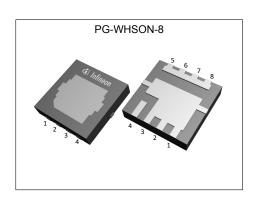
- 100% avalanche tested
- Pb-free lead plating; RoHS compliant
  Halogen-free according to IEC61249-2-21

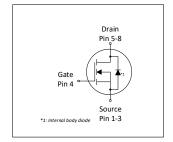
### **Product validation**

Fully qualified according to JEDEC for Industrial Applications

Table 1 **Key Performance Parameters** 

Parameter	Value	Unit
V <sub>DS</sub>	60	V
R <sub>DS(on),max</sub>	3.0	mΩ
I <sub>D</sub>	132	A
Qoss	42	nC
Q <sub>G</sub>	39	nC











Type / Ordering Code	Package	Marking	Related Links
IQE030N06NM5SC	PG-WHSON-8	D	-

# OptiMOS<sup>™</sup> 5 Power-Transistor, 60 V



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## OptiMOS<sup>™</sup> 5 Power-Transistor, 60 V IQE030N06NM5SC



## 1 Maximum ratings at $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Davamatar	Or week at		Value	s	1114	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	- - - -	- - -	132 93 72 21	A	$V_{GS}$ =10 V, $T_{C}$ =25 °C $V_{GS}$ =10 V, $T_{C}$ =100 °C $V_{GS}$ =6 V, $T_{C}$ =100 °C $V_{GS}$ =10 V, $T_{A}$ =25 °C, $R_{thJA}$ =60 °C/W <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	528	Α	<i>T</i> <sub>A</sub> =25 °C
Avalanche energy, single pulse <sup>4)</sup>	<b>E</b> AS	-	-	153	mJ	$I_D$ =20 A, $R_{GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	100 2.5	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =60 °C/W <sup>2)</sup>
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

#### 2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
raiailietei	Symbol	Min.	Тур.	Max.	Ollit	Note / Test Condition
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	1.5	°C/W	-
Thermal resistance, junction - case, top	R <sub>thJC</sub>	-	0.7	-	°C/W	-
Thermal resistance, junction - ambient, 6 cm² cooling area <sup>2)</sup>	R <sub>thJA</sub>	-	-	60	°C/W	-

<sup>&</sup>lt;sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.  $^{2)}$  Device on 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain

connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

<sup>&</sup>lt;sup>4)</sup> See Diagram 13 for more detailed information

# OptiMOS<sup>™</sup> 5 Power-Transistor, 60 V IQE030N06NM5SC



## 3 Electrical characteristics

at T<sub>j</sub>=25 °C, unless otherwise specified

**Table 4** Static characteristics

Parameter.	0	Values			11		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	60	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	
Gate threshold voltage	V <sub>GS(th)</sub>	2.1	2.8	3.3	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=50\ \mu {\rm A}$	
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.5 10	1.0 100	μΑ	V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =60 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C	
Gate-source leakage current	$I_{\mathrm{GSS}}$	-	10	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	2.2 3.3	3.0 5.0	mΩ	V <sub>GS</sub> =10 V, I <sub>D</sub> =20 A V <sub>GS</sub> =6 V, I <sub>D</sub> =5 A	
Gate resistance	R <sub>G</sub>	-	0.9	-	Ω	-	
Transconductance	<b>g</b> fs	-	80	-	S	$ V_{DS}  \ge 2 I_D R_{DS(on)max}, I_D = 30 A$	

Table 5 Dynamic characteristics

Parameter	Ob. a.l.	Values			11	Nata (Tant Oan dition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance <sup>1)</sup>	Ciss	-	2900	3800	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, f=1 MHz
Output capacitance <sup>1)</sup>	Coss	-	600	780	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, f=1 MHz
Reverse transfer capacitance <sup>1)</sup>	C <sub>rss</sub>	-	37	65	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =30 V, f=1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	10	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	5.7	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{ m d(off)}$	-	18.8	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	5.7	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =20 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Table 6 Gate charge characteristics<sup>2)</sup>

Davamatav	Oh. a.l.		Values			Nata (Tant Oan dition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	12.3	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{\mathrm{g(th)}}$	-	8.1	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge <sup>1)</sup>	$Q_{ m gd}$	-	6.8	10.2	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Switching charge	Q <sub>sw</sub>	-	11	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total <sup>1)</sup>	<b>Q</b> g	-	39	49	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate plateau voltage	$V_{ m plateau}$	-	4.2	-	V	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =20 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q <sub>g(sync)</sub>	-	35	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 10 V
Output charge <sup>1)</sup>	Qoss	-	42	56	nC	V <sub>DS</sub> =30 V, V <sub>GS</sub> =0 V

 $<sup>^{1)}</sup>$  Defined by design. Not subject to production test.  $^{2)}$  See "Gate charge waveforms" for parameter definition

# OptiMOS<sup>TM</sup> 5 Power-Transistor, 60 V

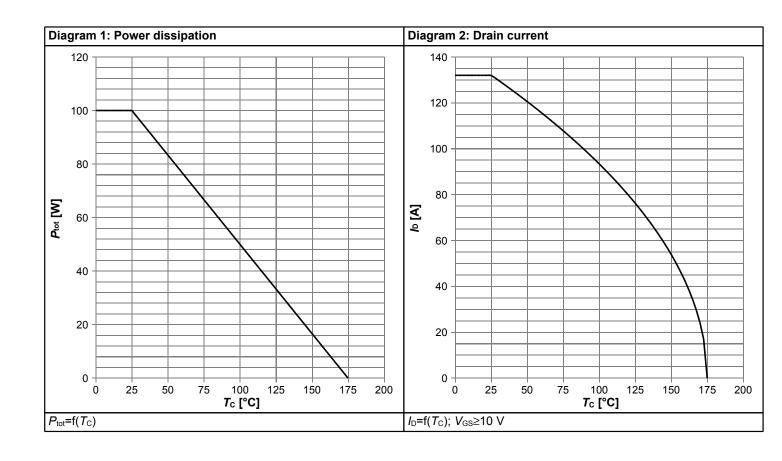


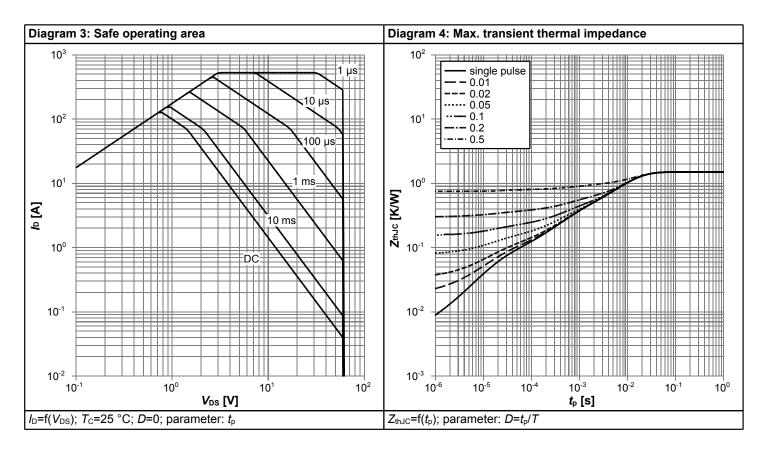
## Table 7 Reverse diode

Danamatan.	Symbol		Values			Nata / Tast Candition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Diode continuous forward current	Is	-	-	68	Α	<i>T</i> <sub>C</sub> =25 °C	
Diode pulse current	I <sub>S,pulse</sub>	-	-	528	Α	<i>T</i> <sub>C</sub> =25 °C	
Diode forward voltage	V <sub>SD</sub>	-	0.82	1.2	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =20 A, T <sub>j</sub> =25 °C	
Reverse recovery time <sup>1)</sup>	t <sub>rr</sub>	-	31	62	ns	$V_R$ =30 V, $I_F$ =20 A, $di_F/dt$ =100 A/ $\mu$ s	
Reverse recovery charge <sup>1)</sup>	Qrr	-	26	52	nC	$V_R$ =30 V, $I_F$ =20 A, $di_F/dt$ =100 A/ $\mu$ s	

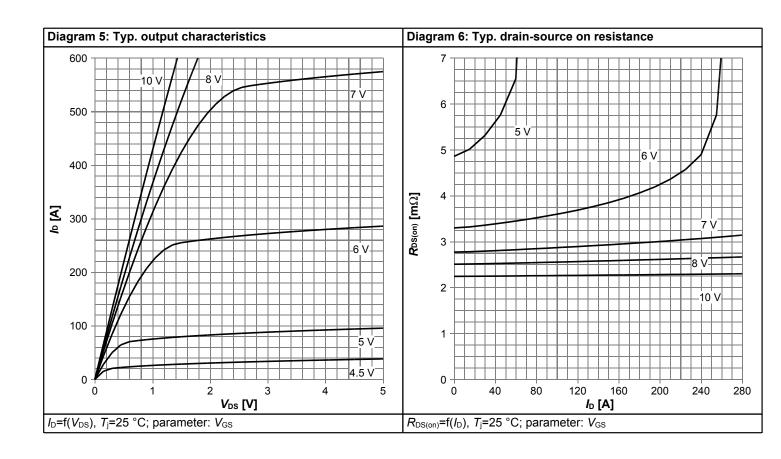


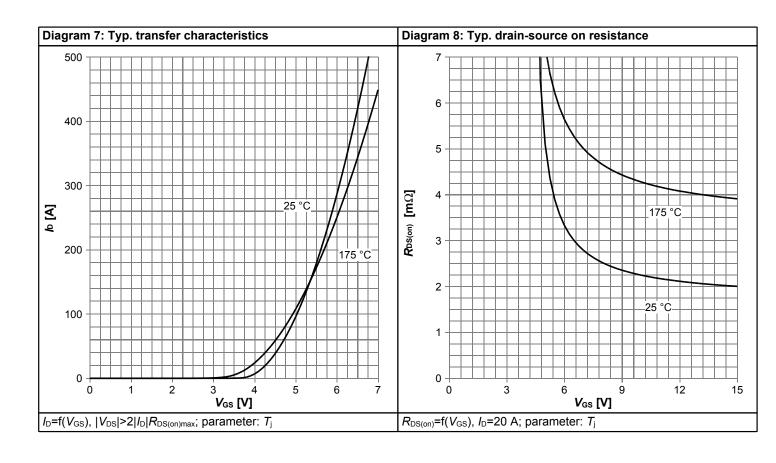
## 4 Electrical characteristics diagrams



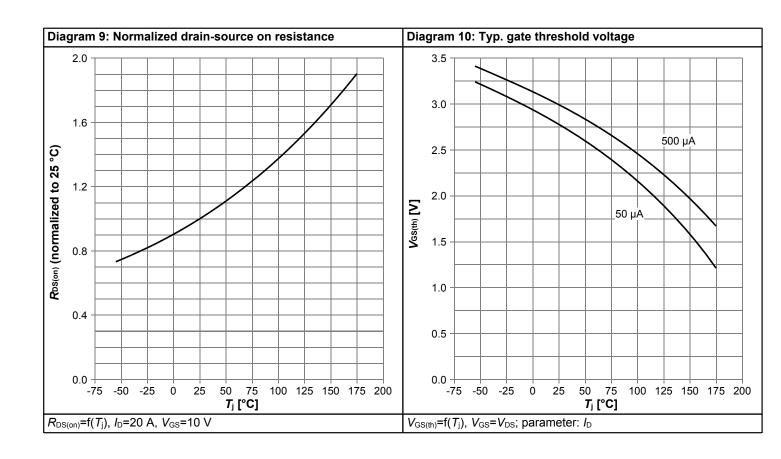


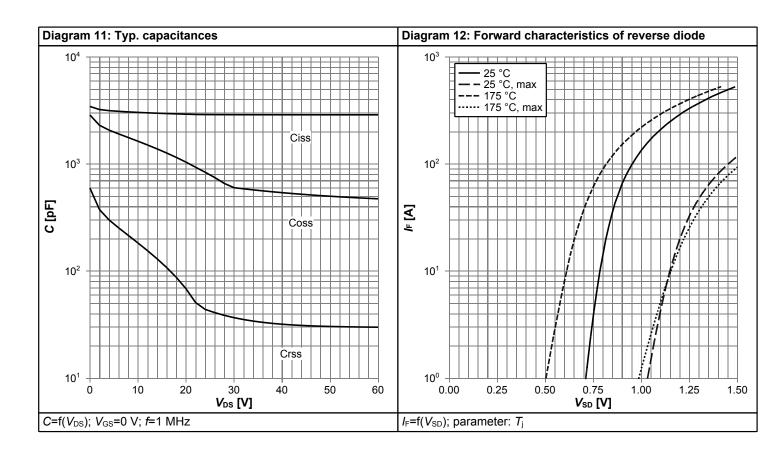




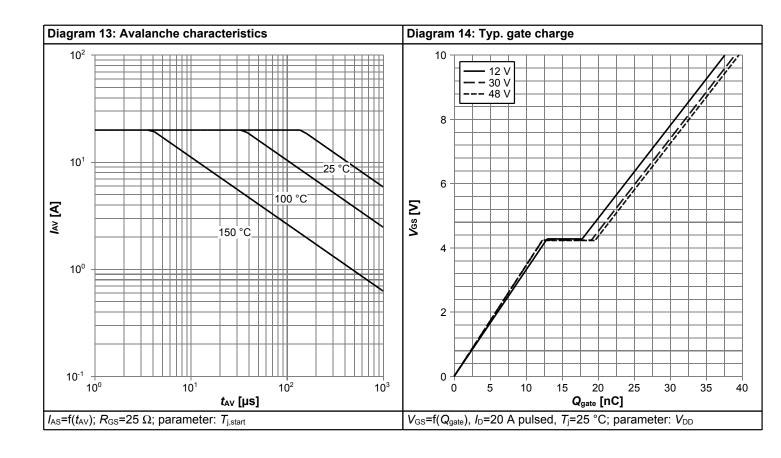


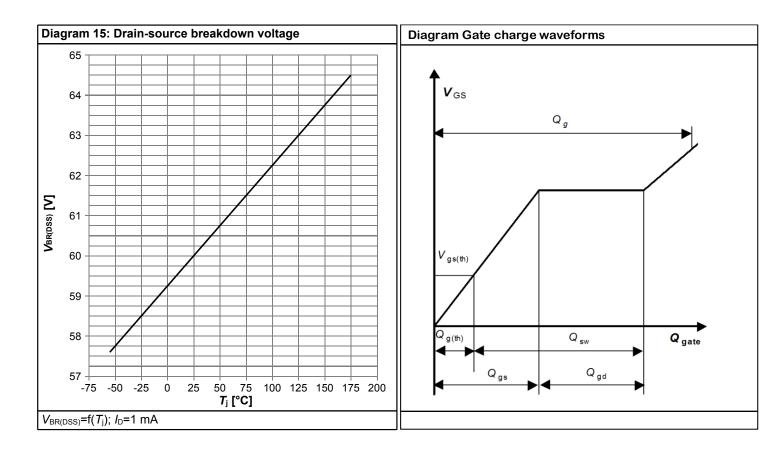






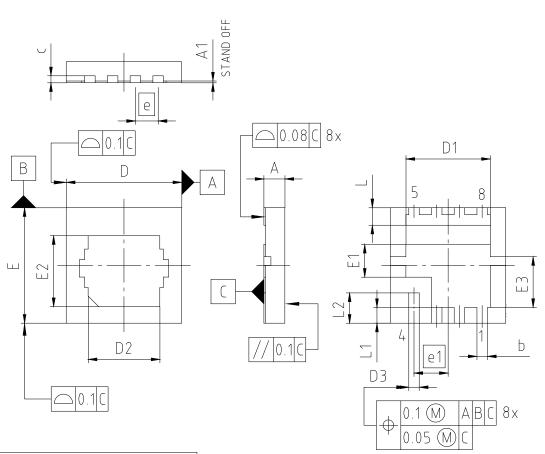








## 5 Package Outlines



PACKAGE - GROUP NUMBER:	PG-WHS	PG-WHSON-8-U01					
DIMENSIONS	MILLIMETERS						
DIMENSIONS	MIN.	MAX.					
Α		0.75					
A1	0	0.05					
b	0.20	0.40					
С	0.10	0.30					
D	3.20	3.40					
D1	2.31	2.51					
D2	1.95	2.25					
D3	0.20	0.40 3.40					
E	3.20						
E1	0.84	1.04					
E2	1.93	2.23					
E3	1.35	1.55					
е	0.65						
e1	0.975						
L	0.40	0.60					
L1	0.35	0.55					
L2	0.77	0.97					

Figure 1 Outline PG-WHSON-8, dimensions in mm



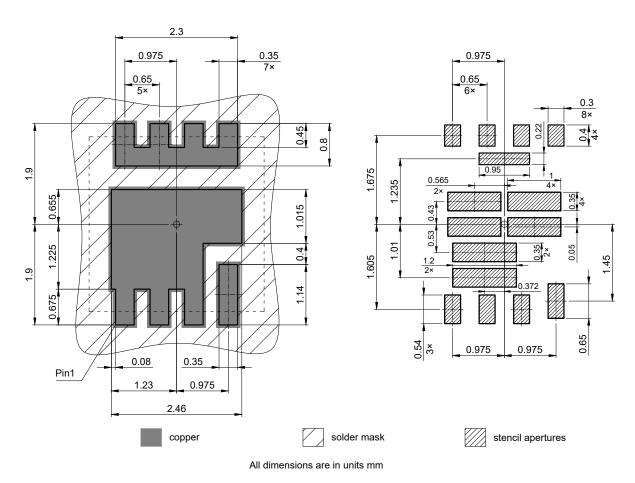


Figure 2 Outline Footprint (PG-WHSON-8-1), dimensions in mm



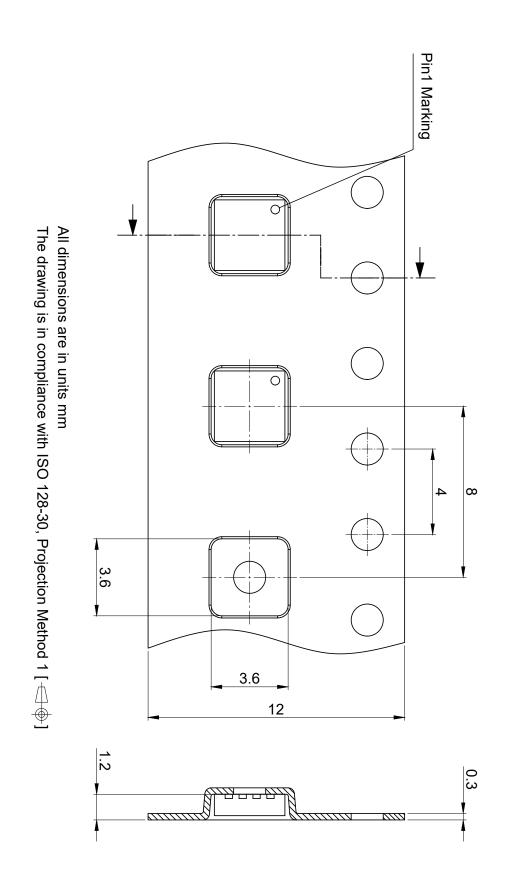


Figure 3 Outline Tape (PG-WHSON-8-1), dimensions in mm

## OptiMOS<sup>™</sup> 5 Power-Transistor, 60 V



#### **Revision History**

IQE030N06NM5SC

Revision: 2022-05-02, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)				
2.0	2022-05-02	Release of final version				

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